#### TOSHIBA TRANSISTOR SILICON NPN TRIPLE DIFFUSED TYPE

# 2 S C 5 4 6 0

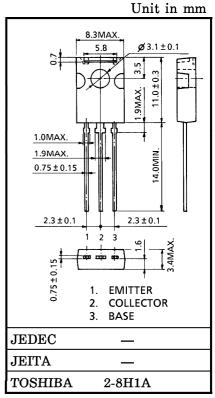
DYNAMIC FOCUS APPLICATIONS

HIGH VOLTAGE SWITCHING APPLICATIONS
HIGH VOLTAGE AMPLIFIER APPLICATIONS

• High Voltage :  $V_{CEO} = 800 \text{ V}$ 

### MAXIMUM RATINGS (Tc = 25°C)

CHARACTERISTIC	SYMBOL RATING		UNIT	
Collector-Base Voltage	$v_{CBO}$	800	V	
Collector-Emitter Voltage	$v_{CEO}$	800	V	
Emitter-Base Voltage	$V_{ m EBO}$	5	V	
Collector Current	$I_{\mathbf{C}}$	50	mA	
Base Current	$I_{\mathbf{B}}$	25	mA	
Collector Power Ta = 25°C	Da	1.5	w	
Dissipation $Tc = 25^{\circ}C$	$^{\mathrm{P}\mathrm{C}}$	10		
Junction Temperature	$T_{j}$	150	°C	
Storage Temperature Range	$\mathrm{T_{stg}}$	-55~150	°C	



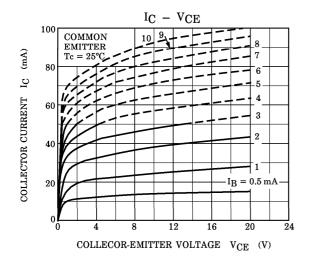
Weight: 0.82 g (Typ.)

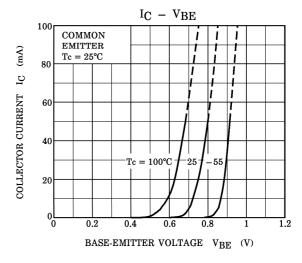
# ELECTRICAL CHARACTERISTICS (Tc = 25°C)

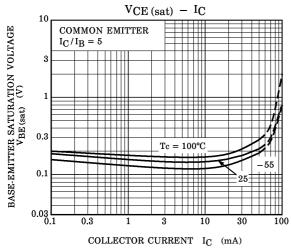
CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Collector Cut-off Current	$I_{CBO}$	$V_{CB} = 640 \text{ V}, I_{E} = 0$	_	_	1.0	$\mu$ <b>A</b>
Emitter Cut-off Current	$I_{EBO}$	$V_{EB} = 5 V, I_{C} = 0$	_	_	10	$\mu$ A
DC Current Gain	$h_{ ext{FE}}$	$V_{CE} = 5 \text{ V}, I_{C} = 7 \text{ mA}$	15	_	_	
Collector-Emitter Saturation	V <sub>CE</sub> (sat)	$I_{\mathrm{C}}=20~\mathrm{mA},~I_{\mathrm{B}}=4~\mathrm{mA}$		_	1.0	V
Voltage						
Base-Emitter Saturation	V <sub>BE (sat)</sub>	$I_{\mathrm{C}}=20\mathrm{mA},~I_{\mathrm{B}}=4\mathrm{mA}$			1.5	V
Voltage						
Transition Frequency	${ m f_T}$	$V_{CE} = 10 \text{ V}, I_{C} = 3 \text{ mA}$	_	5.5		MHz
Collector Output Capacitance	$\mathrm{C_{ob}}$	$V_{CB} = 100 V, f = 1 MHz$	_	2.2	_	рF

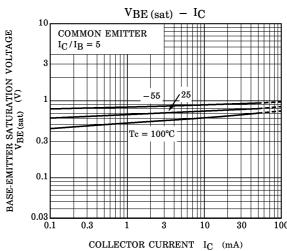
(Note): When an external heat sink is used for the device, insulate using, for example, silicone rubber. When an external heat sink is not used, Toshiba recommends that the plastic part should be at least 2mm away from its surroundings.

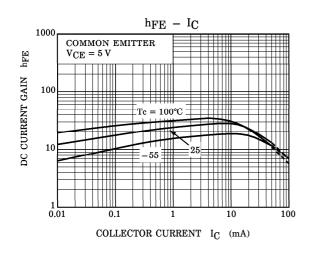
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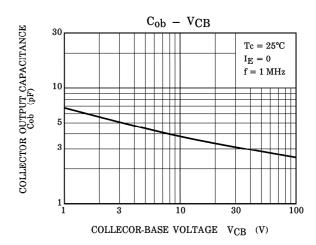




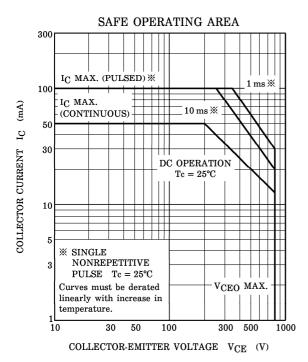








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